

# Search Notes



Application/Control No.

10/027,658

Examiner

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Applicant(s)/Patent under  
Reexamination

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MICHAEL

Art Unit

3629

## SEARCHED

Class	Subclass	Date	Examiner
705	1	11/05	DA
	7		
	8		
395	238		
	604		
	9		
	600		
* 713	202		
	183		
	185		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
I US	11/05	DA
PG Pub Patent		
II FOREIGN		
1. EPO		
2. JPO		
3. Demint		
4. IBM-TOR		